# 30 V P-Channel POWERTRENCH® MOSFET

## **General Description**

This P-Channel MOSFET is a rugged gate version of ON Semiconductor's advanced POWERTRENCH process. It has been optimized for power management applications requiring a wide range of gave drive voltage ratings (4.5 V - 25 V).

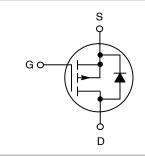
#### **Features**

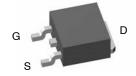
- -40 A, -30 V
  - $R_{DS(ON)} = 20 \text{ m}\Omega @ V_{GS} = -10 \text{ V}$
  - $R_{DS(ON)} = 30 \text{ m}\Omega @ V_{GS} = -4.5 \text{ V}$
- Fast Switching Speed
- High Performance Trench Technology for Extremely Low R<sub>DS(ON)</sub>
- High Power and Current Handling Capability
- Qualified to AEC Q101
- This Device is Pb-Free and are RoHS Compliant



## ON Semiconductor®

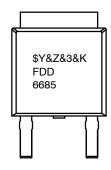
#### www.onsemi.com





DPAK3 (TO-252 3 LD) CASE 369AS

#### **MARKING DIAGRAM**



\$Y = ON Semiconductor Logo &Z = Assembly Plant Code

&3 = Numeric Date Code

kK = Lot Code

FDD6685 = Specific Device Code

## **ORDERING INFORMATION**

See detailed ordering and shipping information on page 2 of this data sheet.

## ABSOLUTE MAXIMUM RATINGS (T<sub>A</sub> = 25°C, Unless otherwise noted)

Symbol	Parameter		Ratings	Units
$V_{DSS}$	Drain-Source Voltage		-30	V
$V_{GSS}$	Gate-Source Voltage		±25	V
I <sub>D</sub>	Continuous Drain Current	@T <sub>C</sub> = 25°C (Note 5)	-40	Α
		@T <sub>A</sub> = 25°C (Note 3a)	-11	
		Pulsed, PW ≤ 100 μs (Note 3b)	-100	
P <sub>D</sub>	Power Dissipation for Single Operation	(Note 3)	52	W
		(Note 3a)	3.8	
		(Note 3b)	1.6	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to +175	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
$R_{ hetaJC}$	Thermal Resistance, Junction-to-Case (Note 3)	2.9	°C/W
$R_{ hetaJA}$	Thermal Resistance, Junction-to-Ambient (Note 3a)	40	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction-to-Ambient (Note 3b)	96	°C/W

<sup>1.</sup> This product has been designed to meet the extreme test conditions and environment demanded by the automotive industry. For a copy of the requirements, see AEC Q101 at http://www.aecouncil.com/

## PACKAGE MARKING AND ORDERING INFORMATION

Part Number	Device	Reel Size	Tape Width	Quantity
FDD6685	FDD6685	13"	16 mm	2500 Units

#### ELECTRICAL CHARACTERISTICS (T<sub>A</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
DRAIN-SOUR	CE AVALANCHE RATINGS (NOTE 4)	•				
E <sub>AS</sub>	Single Pulse Drain-Source Avalanche Energy	I <sub>D</sub> = -11 A		42		mJ
I <sub>AS</sub>	Maximum Drain-Source Avalanche Current			-11		Α
OFF CHARACT	TERISTICS	•				
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-30			V
$\Delta BV_{DSS} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = -250 μA, Referenced to 25°C		-24		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = -24 V, V <sub>GS</sub> = 0 V			-1	μΑ
I <sub>GSS</sub>	Gate-Body Leakage	$V_{GS} = \pm 25V, V_{DS} = 0 V$			±100	nA
ON CHARACT	ERISTICS					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-1	-1.8	-3	V
$\Delta V_{GS(th)} / \Delta T_{J}$	Gate Threshold Voltage Temperature Coefficient	$I_D$ = -250 $\mu$ A, Referenced to 25°C		5		mV/°C
R <sub>DS(on)</sub>	Static Drain-Source	$V_{GS} = -10 \text{ V}, I_D = -11 \text{ A}$		14	20	mΩ
	On-Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -9 \text{ A}$		21 20	30	
		$V_{GS} = -10 \text{ V}, I_D = -11 \text{ A}, T_J = 125^{\circ}\text{C}$				

<sup>2.</sup> All ON Semiconductor products are manufactured, assembled and tested under ISO9000 and QS9000 quality systems certification.

## FI FCTRICAL CHARACTERISTICS (T<sub>A</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
ON CHARACT	TERISTICS					
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS} = -10 \text{ V}, V_{DS} = -5 \text{ V}$	-20			Α
9FS	Forward Transconductance	V <sub>DS</sub> = -5 V, I <sub>D</sub> = -11 A		26		S
DYNAMIC CH	ARACTERISTICS					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$		1715		pF
C <sub>oss</sub>	Output Capacitance			440		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			225		pF
$R_{G}$	Gate Resistance	V <sub>GS</sub> = 15 mV, f = 1.0 MHz		3.6		Ω
SWITCHING C	CHARACTERISTICS	•				
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = -15 \text{ V}, I_D = -1 \text{ A}, V_{GS} = -10 \text{ V},$ $R_{GEN} = 6 \Omega$		17	31	ns
t <sub>r</sub>	Turn-On Rise Time			11	21	ns
t <sub>d(off)</sub>	Turn-Off Delay Time			43	68	ns
t <sub>f</sub>	Turn-Off Fall Time			21	34	ns
Qg	Total Gate Charge	$V_{DS} = -15V$ , $I_D = -11 A$ , $V_{GS} = -5 V$		17	24	nC
Q <sub>gs</sub>	Gate-Source Charge			9		nC
Q <sub>gd</sub>	Gate-Drain Charge			4		nC
DRAIN-SOUR	CE DIODE CHARACTERISTICS AND M	AXIMUM RATINGS				
$V_{SD}$	Drain-Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = -3.2 A (Note 4)		-0.8	-1.2	V
Trr	Diode Reverse Recovery Time	IF = -11 A,		26		ns
Qrr	Diode Reverse Recovery Charge	diF/dt = 100 A/μs		13		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### NOTES:

mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



4. Pulse Test: Pulse Width < 300  $\mu$ s, Duty Cycle < 2.0%

5. Maximum current is calculated as:  $\overline{R}_{DS(ON)}$ 

where  $P_D$  is maximum power dissipation at  $T_C$  = 25°C and  $R_{DS(on)}$  is at  $T_{J(max)}$  and  $V_{GS}$  = 10 V. 6. Starting  $T_J$  = 25°C, L = 0.69 mH,  $I_{AS}$  = -11 A

#### **TYPICAL CHARACTERISTICS**

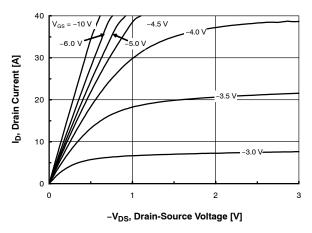


Figure 1. On-Region Characteristics

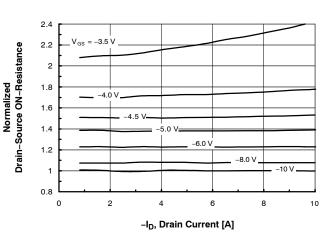


Figure 2. On–Resistance Variation with Drain Current and Gate Voltage

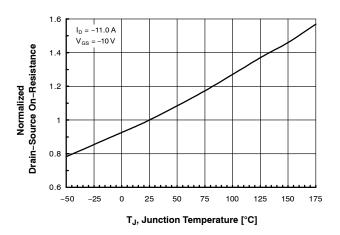


Figure 3. On-Resistance Variation with Temperature

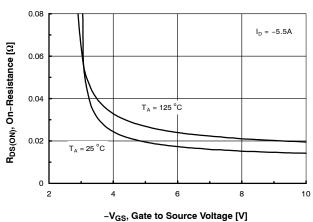


Figure 4. On-Resistance Variation with Gate-to-Source Voltage

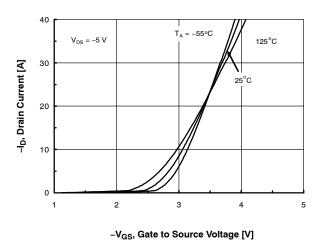
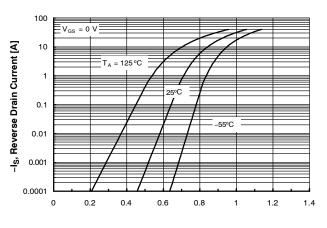


Figure 5. Transfer Charactersistics



-V<sub>SD</sub>, Body Diode Forward Voltage [V]

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature

## TYPICAL CHARACTERISTICS (continued)

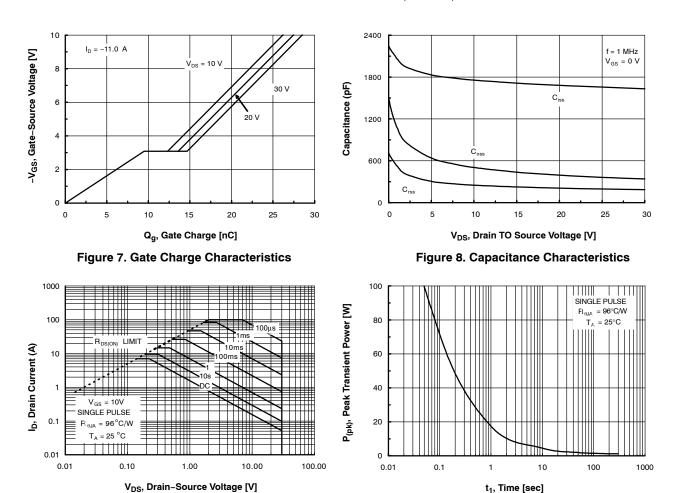


Figure 9. Maximum Safe Operating Area

Figure 10. Single Pulse Minimum Power Dissipation

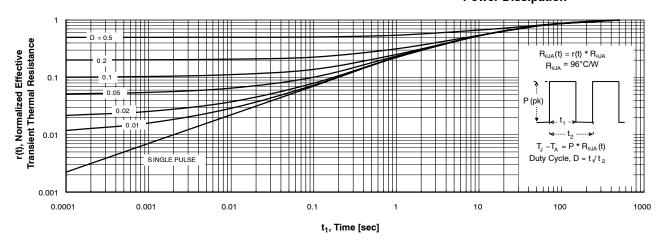
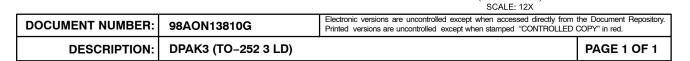


Figure 11. Transient Thermal Response Curve

- NOTES:
- 7. Thermal characterization performed using the conditions described in Note 3b.
- 8. Transient thermal response will change depending on the circuit board design.

POWERTRENCH registered trademarks of Semiconductor Components Industries, LLC (SCILLC) or its subsidiaries in the United States and/or other countries.

#### DPAK3 (TO-252 3 LD) CASE 369AS **ISSUE O DATE 30 SEP 2016** 6.73 6.35 5,46 5.55 MIN-6.50 MIN 6.40 Ċ 0.25 MAX PLASTIC BODY STUB MIN DIODE PRODUCTS VERSION (0.59)-1.25 MIN 0.89 ⊕ 0.25 M AM C 2.29 2.28 4.56 4.57 LAND PATTERN RECOMMENDATION NON-DIODE PRODUCTS VERSION В 2.39 SEE 2.18 4.32 MIN **NOTE D** 0.58 0.45 5.21 MIN 10.41 9.40 SEE DETAIL A 2 3 NON-DIODE PRODUCTS VERSION DIODE PRODUCTS VERSION ○ 0.10 B 0,51 **GAGE PLANE** NOTES: UNLESS OTHERWISE SPECIFIED 0.61 0.45 A) THIS PACKAGE CONFORMS TO JEDEC, TO-252, (1.54)ISSUE C, VARIATION AA. B) ALL DIMENSIONS ARE IN MILLIMETERS. C) DIMENSIONING AND TOLERANCING PER 10° ASME Y14.5M-2009. D) SUPPLIER DEPENDENT MOLD LOCKING HOLES OR CHAMFERED 1 78 CORNERS OR EDGE PROTRUSION.



ON Semiconductor and (III) are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

E TRIMMED CENTER LEAD IS PRESENT ONLY FOR DIODE PRODUCTS

G) LAND PATTERN RECOMENDATION IS BASED ON IPC7351A STD TO228P991X239-3N.

F) DIMENSIONS ARE EXCLUSSIVE OF BURSS,

MOLD FLASH AND TIE BAR EXTRUSIONS.

0.127 MAX

**DETAIL A** (ROTATED -90°)

**SEATING PLANE** 

1,40

(2.90)

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at <a href="www.onsemi.com/site/pdf/Patent-Marking.pdf">www.onsemi.com/site/pdf/Patent-Marking.pdf</a>. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer pu

#### **PUBLICATION ORDERING INFORMATION**

LITERATURE FULFILLMENT: Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative

# **X-ON Electronics**

Largest Supplier of Electrical and Electronic Components

Click to view similar products for MOSFET category:

Click to view products by ON Semiconductor manufacturer:

Other Similar products are found below:

614233C 648584F IRFD120 JANTX2N5237 FCA20N60\_F109 FDZ595PZ 2SK2545(Q,T) 405094E 423220D TPCC8103,L1Q(CM MIC4420CM-TR VN1206L SBVS138LT1G 614234A 715780A NTNS3166NZT5G SSM6J414TU,LF(T 751625C BUK954R8-60E NTE6400 SQJ402EP-T1-GE3 2SK2614(TE16L1,Q) 2N7002KW-FAI DMN1017UCP3-7 EFC2J004NUZTDG ECH8691-TL-W FCAB21350L1 P85W28HP2F-7071 DMN1053UCP4-7 NTE221 NTE222 NTE2384 NTE2903 NTE2941 NTE2945 NTE2946 NTE2960 NTE2967 NTE2969 NTE2976 NTE455 NTE6400A NTE2910 NTE2916 NTE2956 NTE2956 NTE2911 DMN2080UCB4-7 TK10A80W,S4X(S SSM6P69NU,LF DMP22D4UFO-7B